

The ESA family of spectrum analyzers have proven and guaranteed performance with the flexibility to select the right level of functionality for your test needs. Take advantage of the best overall performance on a mid-performance spectrum analyzer.

Industry best typical performance

- Warm up time: 5 minutes
- Third order intermodulation distortion: +16 dBm
- Sensitivity: -166 dBm
- Amplitude accuracy: ± 0.4 dB
- Overall phase noise (all carrier frequencies^a):
 -94 dBc/Hz (10 kHz)
 - -122 dBc/Hz (100 kHz)
 - -136 dBc/Hz (1 MHz)

a. Add 20LogN for frequencies > 6.7 GHz, where N is the harmonic mixing mode.

Agilent ESA Series Spectrum Analyzers Data Sheet

Express analyzer configurations

- Basic Analyzer Express Option BAS
- Standard Analyzer
 Express Option STD
- Communications Test Analyzer Express Option COM





Definitions and Conditions

The distinction between specifications and characteristics is described as follows.

- Specifications describe the performance of parameters covered by the product warranty. (The temperature range is 0 °C to 55 °C, unless otherwise noted.)
- Characteristics describe product performance that is useful in the application of the product, but is not covered by the product warranty.
- Typical performance describes additional product performance information that is not covered by the product warranty. It is performance beyond specification that 80% of the units exhibit with a 95% confidence level over the temperature range 20 to 30 °C. Typical performance does not include measurement uncertainty.
- Nominal values indicate the expected performance, or describe product performance that is useful in the application of the product, but is not covered by the product warranty.

The following conditions must be met for the analyzer to meet its specifications.

- The analyzer is within the one year calibration cycle.
- If Auto Align All is selected:
 - After 2 hours of storage within the operating temperature range.
 - 5 minutes after the analyzer is turned on with sweep times less than 4 seconds.
- If Auto Align Off is selected:
 - When the analyzer is at a constant temperature, within the operating temperature range, for a minimum of 90 minutes.
 - After the analyzer is turned on for a minimum of 90 minutes and **Align Now All** has been run.
 - When **Align Now All** is run:
 - Every hour
 - If the ambient temperature changes more than 3 $^{\circ}\mathrm{C}$
 - If the 10 MHz reference changes
 - If Auto Align All but RF is selected:
 - When the analyzer is at a constant temperature, within the operating temperature range, for a minimum of 90 minutes.
 - After the analyzer is turned on for a minimum of 90 minutes and **Align Now RF** has been run.
 - When **Align Now RF** is run:
 - Every hour
 - If the ambient temperature changes more than 3 $^{\circ}\mathrm{C}$

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Frequency range	E4411B	E4403B	E4408B
BAS configuration	9 kHz - 1.5 GHz	9 kHz - 3 GHz	9 kHz - 26.5 GHz
Custom configuration	(75 Ω input Option 1DP) 1 MHz - 1.5 GHz	N/A	N/A

Frequency range	E4402B	E4404B	E4405B	E4407B
STD or COM configuration	9 kHz - 3 GHz	9 kHz – 6.7 GHz	9 kHz – 13.2 GHz	9 kHz - 26.5 GHz
Low frequency extension Option	on UKB			
Custom configuration	100 Hz ^a - 3 GHz	100Hz ^a - 6.7 GHz	100Hz ^a - 13.2 GHz	100Hz ^a - 26.5 GHz External mixing Option AYZ Add 18 GHz - 325 GHz

Frequency range	100 Hz - 3 GHz	2.85 - 6.7 GHz	6.2 - 13.2 GHz	12.8 – 19.2 GHz	18.7 – 26.5 GHz
Band	0	1	2	3	4
Harmonic (N ^b) mixing mode	1-	1-	2-	4-	4-

a. 30 Hz characteristic.
b. N = LO harmonic mixing mode.

		Basic analyzer	Standard analyzer	Communications test analyzer or ESA with Option 1D5	
Frequency referenc	e	-		•	
Frequency reference	ce error $= \pm [(aging rate)]$	x time since last adjustr	nent)+ settability + temper	ature stability]	
Frequency readout = ±(frequency indica	accuracy (start, stop, cen ation x frequency referen	nter, marker) ce error + SP ^C +15% of RI	3W + 10 Hz + 1 Hz x N ^a)		
			±2 x 10 ⁻⁶ ⁄year		
Aging rate		\pm 2 x 10 $^{-6}$ /year	±1 x 10 ⁻⁷ /year	\pm 1 x 10 ⁻⁷ /year	
			(Opt. 1D5)		
			±5 x 10 ⁻⁶ ⁄year		
Temperature stabilit	У	\pm 5 x 10 $^{-6}$ /year	±1 x 10 ⁻⁸ /year ^b	±1 x 10–8/year ^b	
			(Opt. 1D5)		
			±5 x 10 ⁻⁷ /year		
Settability		\pm 5 x 10 $^{-7}$ /year	±1 x 10 ⁻⁸ /year	±1 x 10 ⁻⁸ /year	
			(Opt. 1D5)		
		0.75 % x span	[0.5 % + 1/ (sweep	[0.5 % + 1/ (sweep	
Span coefficient (SF	p) ^C	0.75 % x Span	points –1)] x span	points –1)] x span	
External reference		10 MHz	10 MHz	1 - 30 MHz	
Marker frequency of	counter ^d				
Accuracy = \pm (marker frequency x frequency reference error + counter resolution) Counter resolution = selectable from 1 Hz to 100 kHz					
Frequency span					
Range = 0 Hz (zero	span), 100 Hz to maximu	m frequency range of the	analyzer		
Accuracy	Swp type linear	1% of span	\pm [0.5% x span + 2 x span	/(sweep points – 1)]	
	Logarithmic	N/A	2% of span	, nominal	

Span coefficient of frequency readout accuracy. Sweep points fixed at 401 for C. basic analyzer.
d. Not available in RBW < 1 kHz (Option 1DR).

N = LO harmonic mixing mode. 20 to 30 °C. a.

b.

		Basic analyzer	Standard analyzer or ESA with Option AYX	Communications test analyzer or ESA with Option B7D/B7E		
Sweep time an	d trigger					
Span = 0 Hz		4 ms – 4000 s	50 ns ^a – 4000 s	25 ns ^a - 4000 s		
Range	Span≥100 Hz	4 ms – 4000 s	1 ms-	4000 s		
Accuracy		± 1%				
L		Free Run, Single, Line, Video, Offset, Delayed, External				
Trigger type ^b		Gate (1D6)				
				RF burst (B7E)		
Delayed trigger	range		1 us to 400 s			
Sweep (trace)	points					
2	Span = 0 Hz	401	2 -	8192		
Range	Span≥100 Hz	401	101	- 8192		

	Basic analyzer	Standard analyzer	Communications test analyzer or ESA with Option 1DR and 1D5		
Resolution bandwidths (1-3-10 s	equence)				
Range					
(-3 dB)	1 kHz – 5 MHz	1 kHz – 5 MHz	1 Hz to 5 MHz		
(-6 dB EMI)	9 KHz, 120 kHz	9 KHz, 120 kHz	200 Hz, 9 kHz,120 kHz		
With 1DR ^c (-3dB)	Add 100 Hz, 300 Hz	Add 10 Hz - 300 Hz	Included		
(-6 dB EMI)	Add 200 Hz	200 Hz	menudeu		
With 1DR and 1D5 ^d	N/A	Add 1 Hz and 3 Hz	Included		
Accuracy					
1 Hz to 300 Hz		±10%			
1 kHz to 3 MHz		± 15%			
5 MHz		± 30%			
Selectivity (60 dB/3 dB bandwidth	ı ratio)				
100 Hz to 300 Hz		< 5:1 digital, approximately Ga	ussian		
1 kHz to 5 MHz	< 15:1 synchronously tuned four poles, approximately Gaussian				
Video bandwidths (1-3-10 sequence)					
Range	30 Hz to 3 MHz				
with 1DR		Adds 1, 3, 10 Hz for RBWs less t	han 1 kHz		

a. RBW ≥ 1 kHz, 2 sweep points.
b. TV trigger available with option B7B in custom configuration for ESA-E.
c. Only available for spans < 5MHz.
d. Firmware revision A.08.00 and later.

	Basic analyzer		Standard and communications test analyzer	ESA-E	
	E4411B	E4403B/08B	E4402B/04B/05B/07B	with Option 120 ^a	
Stability					
Noise sidebands offset	from CW signal with 1 l	kHz RBW, 30 Hz VBW aı	nd sample detector		
Offset from CW signal	Sp	ec, typical dBc/Hz applies	s to all frequencies \leq 6.7 GHz ^{b, c}		
≥1 kHz			-78 dBc/Hz (Option 1D5)		
≥10 kHz	-93, -95 dBc/Hz	-90, <i>-94 dBc/Hz</i>	-90, -94 dBc/Hz		
≥ 20 kHz	-100, - <i>102 dBc/Hz</i>	-100, <i>-105 dBc/Hz</i>	-100, - <i>105 dBc/Hz</i>		
≥ 30 kHz	-104, -106 dBc/Hz	-106, <i>-112 dBc/Hz</i>	-106, - <i>112 dBc/Hz</i>		
≥ 100 kHz	-113, -116 dBc/Hz	-118, - <i>122 dBc/Hz</i>	-118, - <i>122 dBc/Hz</i>		
≥1 MHz			-125, - <i>127 dBc/Hz</i>	-133, <i>-136 dBc/Hz</i>	
≥5 MHz			-127, - <i>129 dBc/Hz</i>	-135, <i>-139 dBc/Hz</i>	
≥ 10 MHz			-131, - <i>136 dBc/Hz</i>	-137, -141 dBc/Hz	
Residual FM (peak-to-	peak)				
1 kHz RBW, 1 kHz VBW	≤ 150 Hz x N ≤ 30 Hz x N ^C (20	J ^C (100 ms) I ms), Option 1DR	≤ 150 Hz x N ^C (100 ms) ≤ 10 Hz x N ^C (20 ms), Option 1DR ≤ 2 Hz peak-to-peak x N ^C , (20 ms), Option 1DR & 1D5		
Option 1D5 only 100 ms			\leq 100 Hz x N ^C		
Option 1DR only 20 ms			\leq 10 Hz x N ^C		
Option 1DR & 1D5 20 ms	\leq 2 Hz peak-to-peak x N ^C				
System related sideba	nds				
≥ 30 kHz offset from carrier CW signal			\leq -65 dBc + 20logN ^C		

Noise Sidebands Normalized to 1 Hz Versus Offset from Carrier

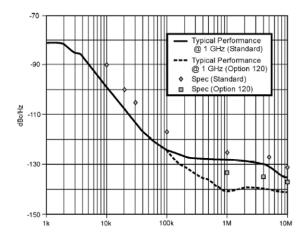


Figure 1. Typical ESA-E Series performance at 1 GHz

a. Enhanced wide offset phase noise and ACPR dynamic range.

b. Add 20log(N) for frequencies > 6.7 GHz. N=LO Harmonic mixing number.

C.

		E4411B	E4403B/08B	E4402B	E4404B/05B	E4407B		
	Amplitude range							
Measurem	ent range	Displ	Displayed average noise level (DANL) to maximum safe input level					
Input atten (5 dB step	uator range)	0 – 60 dB	0 – 65 dB	0 – 75 dB	0 – 75 dB	0 – 65 dB		
Maximum safe input level								
Input atte	nuator setting	\geq 15 dB	≥ 5 dB a	average continuous	power; \geq 30 dB p	eak pulse power		
Average c	continuous power	+30 dBm	+30 dBm (1 W)		+30 dBm (1 W)		
Peak puls	e power	– (1 W)	+50 dBm (100 W)		+50 dBm (100 \	N)		
DC	DC coupled			0 Vdc (Option UKB)	0 Vdc	0 Vdc		
voltage	AC coupled	100 Vdc +75 dBmV (0.4 W) Option 1DP	100 Vdc	100 Vdc 50 Vdc (Opt. UKB)	50 Vdc	50 Vdc (Opt. UKB)		
1 dB gain compression Two tone								
Total power at input mixer ^a 50 MHz to 6.7 GHz 0 dBm to 1.5 GHz 0 dBm								
	to 13.2 GHz	46.75 dBmV (1DP)	-3 dBm					
13.2 GH	lz to 26.5 GHz			-5 d	Bm			

a. Mixer power level (dBm) = input power (dBm) minus input attenuation (dB).

	Basic analyzer		Standa	ard analyzer	Communications test analyzer or ESA with 1DR and 1D5		
	E4411B	E4403B	E4408B	E4402B	E4404/05B/07B	E4402B	E4404/05/7B
Displayed average	Displayed average noise level (dBm) (input terminated, 0 dB attenuation, sample detector) spec, typical						
Conditions		100 Hz RBW; 1 Hz VB	W (Option 1DR);	10 Hz RBW/1 Hz	VBW (Option 1DR)		W/VBW DR and 1D5)
Frequency 1 MHz - 10 MHz	-123, typ -129	typ -126	typ -129	typ -139	typ-137, -139 ^a	typ-146, -149 ^a	typ-147, -149 ^{.a}
10 MHz - 500 MHz 500 MHz - 1 GHz	-127, typ -131 -125, typ -130	-125, typ -130	-124, typ -129	-136, typ -140	-135, typ-139		typ -149
1 GHz - 1.5 GHz 1.5 GHz - 2 GHz	-121, typ -128	-124, typ -130	-123, typ -130	-135, typ -140	-135, typ -140	typ-150	typ -150
2 GHz - 3 GHz 3 GHz - 6 GHz		-122, typ -120	-120, typ -128	-133, typ -140	-131, typ-138		typ -148
6 GHz - 12 GHz 12 GHz - 22 GHz			-118, typ -127 -115, typ -124		-130, typ -137 -126, typ -134		typ -147 typ -144
22 GHz - 26.5 GHz	noise level (dBm) w	ith DE proomplifier ^D	-109, typ -122		-125, typ-132		typ -142
1 MHz - 10 MHz 10 MHz - 1 GHz 1 GHz - 2 GHz	iioise ievel (ubiii) w	iui ni predilipililei		typ-152 -152, typ -156 -152, typ -156	typ -155 -151, typ -157 -151, typ -155	typ -162 typ -166 typ -166	typ -165 typ -167 typ -165
2 GHz - 3 GHz				-151, typ-154	-149, typ -152	typ -164	typ -162

a. b.

Custom path only, Option 120, typical. 20 to 30° C. For 0 to 55 °C range, see specifications guide.

	Basic analyzer	Standard analyzer or ESA with Option AYX	Communications test analyzer or ESA with Option B7D/B7E				
Display	•	· ·					
Display range	0.1, 0.2, 0.5 dB/division and 1 to 20 dB/division in 1 dB steps (10 display divisions)						
Log scale							
$RBW \ge 1 kHz$	Calibrated	l 0 to -85 dB from reference le	evel				
$RBW \le 300 Hz$	Calibrated	0 to -120 dB ^a from reference le	evel				
Linear scale		10 divisions					
Scale units	dBm, dBmV, dBμV, dBμA, A, V, and W		A, V, W and Hz (Option BAA)				
Trace detectors		gative peak, sample, rms, avera					
Trace functions	Clear/write, max. h	nold, min. hold, view, blank, op	erations, normalize				
Display resolution ^b		640 x 480					
Marker readout resolution							
Log scale							
0 to - 85 dB		0.04					
0 to -120 dB (1DR)							
Linear scale		0.01% of reference level					
Reference level							
Range	—149.9 dBn	n to maximum mixer level + a	attenuator setting				
Resolution		±0.1 dB					
Log scale							
Linear scale		\pm 0.12% of reference leve	1				
Accuracy ^C							
For reference level (dBm) –	nput attenuator setting (dB) + pre	amp gain (dB)					
-10 dBm to > -60 dBm		± 0.3 dB					
-60 dBm to > -85 dBm		\pm 0.5 dB					
-85 dBm to > -90 dBm		\pm 0.7 dB					
Display scale switching unce	rtainty (referenced to 1 kHz at refere	nce level)					
Linear to log switching	± 0.15 dB at reference level						
Resolution bandwidth switching uncertainty (referenced to 1 kHz at reference level)							
1 Hz to 10 Hz RBW		± 0.3 dB	± 0.3 dB				
1 Hz to 10 Hz RBW 100 Hz to 3 MHz RBW	± 0.3 dB (1DR)	± 0.3 dB (1DR, 1D5)	± 0.3 dB ± 0.3 dB				

<sup>a. 0 to -70 dB range when span = 0 Hz, or when IF gain fixed.
b. The LCD display is manufactured using high precision technology. However, there may be up to six bright points (white, blue, red or green in color) that constantly appear on the LCD screen. These points are normal in the manufacturing process and do not affect the measurement integrity of the product in any way.
c. 50 Ω, accuracy (at a fixed frequency, a fixed attenuator, and referenced to -35 dBm (-10 dBm, Preamp On (Option 1DS))).</sup>

	Basic analyzer	Standard, communications test analyzer or custom configuration			
Input attenuator switching uncertainty	/ (at 50 MHz)				
Attenuator setting 0 dB to 5 dB	\pm 0.3 dB				
10 dB	Reference				
15 dB	+ (0 1 dB + 0 (01 x attenuator setting)			
20 dB to 60 dB					
Frequency response (10 dB input attenua	tion)				
Absolute ^a /typical/relative ^b 100 Hz to 9 kHz ^c		\pm 0.5 dB/NA/ \pm 0.5 dB			
9 kHz to 3 GHz	\pm 0.5 dB/NA/ \pm 0.5 dB	\pm 0.46 dB/± 0.14 dB/± 0.5 dB \pm 0.5 dB/NA/± 0.5 dB^a (Option UKB)			
3 GHz to 6.7 GHz	\pm 1.5 dB/NA/ \pm 1.3 dB	\pm 1.5 dB/ \pm 0.38 dB/ \pm 1.3 dB			
6.7 GHz to 13.2 GHz	\pm 2 dB/NA/ \pm 1.8 dB	\pm 2 dB/ \pm 0.68 dB/ \pm 1.8 dB			
13.2 GHz to 26.5 GHz	± 2 db/ NA/ ± 1.0 db	\pm 2 dB/ \pm 0.86 dB/ \pm 1.8 dB			
Absolute amplitude accuracy					
At reference settings ^d	\pm 0.4dB	\pm 0.34 dB, \pm 0.16 dB typical			
Preamp on		\pm 0.37 dB, \pm 0.14 dB typical			
Overall amplitude accuracy ^e	\pm (0.6dB + absolute frequency response)	\pm (0.54 dB + absolute frequency response)			
(95% confidence) ^f		\pm 0.4 dB (95%)			
Display scale fidelity					
Log max cumulative					
dB below reference level					
$RBW \ge 1 kHz$		0 dB			
0 dB reference					
> 0 to 10 dB	± (0.3dB + 0.01 x dB	\pm 0.3 dB, typ \pm 0.08 dB			
> 10 to 20 dB	from reference level	±0.4 dB, typ ±0.09 dB			
> 20 to 30 dB		\pm 0.5 dB, typ \pm 0.1 dB			
> 30 to 40 dB		±0.6 dB, typ ±0.23 dB			
> 40 to 50 dB		±0.7 dB, typ ±0.35 dB			
> 50 to 60 dB		±0.7 dB, typ ±0.35 dB			
> 60 to 70 dB		±0.8 dB, typ ±0.39 dB			
> 70 to 80 dB > 80 to 85 dB		±0.8 dB, typ ±0.46 dB ±1.15 dB, typ ±0.79 dB			
		±1.15 dB; typ ±0.79 dB			
RBW ≤ 300 Hz (Option 1DR) span > 0 Hz, auto range on 0 to 98 dB ^g 0 to 98 dB ^g	± (0.3dB + 0.01 x dB from reference level)				
> 98 to 120 dB	\pm 2.0 dB from reference level, characteristic				
Log incremental accuracy dB below reference level 0 to 80 dB ^g	± 0.4 dB / 4 dB				
Linear accuracy	± 2% of re	ference level			

a. Frequency response values are referenced to the amplitude at 50 MHz (20 to 30 °C).

Referenced to midpoint between highest and lowest frequency response deviations (20 to 30 °C).

c. Custom path ESA-E only Option UKB, typical.

d. Settings are: reference level -25 dBm; (75 Ω reference level +28.75 dBmV); input attenuation 10 dB; center frequency 50 MHz; RBW 1 kHz; VBW 1 kHz; amplitude scale linear or log; span 2 kHz; frequency scale linear; sweep time coupled, sample detector, signal at reference level.

e. For reference level 0 to -50 dBm; input attenuation 10 dB; RBW 1 kHz; VBW 1 kHz; amplitude scale log, log range 0 to -50 dB from reference level; frequency scale linear; sweep time coupled; signal input 0 to -50 dBm; span ≤ 20 kHz. (20 to 30 °C).

f. Input frequency < 3GHz; -50 dBm \leq input power \leq 0 dBm; -50 dBm \leq reference level \leq 0 dBm; -20 dB \leq input power - ref level \leq 0 dB; input attenuation = 10 dB; 10 Hz \leq RBW \leq 1 MHz; (20 to 30 °C). Computed from the observation of a statistically significant number of instruments. Observations of the 50 MHz amplitude accuracy, a component of the computation of this number are performed immediately after invoking RF and IF alignments to minimize the effects of alignment drifts.

g. 0 to 30 dB for RBW = 200 Hz.

	Basic analyzer E4411B/03B/08B	Standard, communications test analyzer or customer configuration E4402B/04B/05B/07B	
Spurious responses			
Third order intermodulation distortion	For two -30 dBm signals at inpu	t mixer ^a and > 50 kHz separation	
10 MHz to 100 MHz			
100 MHz to 3 GHz		< -85 dBc, +12.5 dBm; typ +16 dBm TOI	
3.0 GHz to 6.7 GHz	< -75 dBc, + 7.5 dBm T0I	< -82 dBc, +11 dBm; typ +18 dBm TOI	
6.7 GHz to 13.2 GHz		< -75 dBc, +7.5 dBm; typ +12 dBm TOI	
13.2 GHz to 26.5 GHz		< -75 dBc, +7.5 dBm; typ +11 dBm TOI	
Second harmonic distortion			
2 MHz to 750 MHz - 40 dBm tone at input mixer ^a	< -75 dBc, + 35 dBm SHI (E4411B)		
10 MHz to 500 MHz - 30 dBm tone at input mixer ^a	< -60 dBc, + 30 dBm SHI	< -65 dBc, + 35 dBm SHI	
500 MHz to 1.5 GHz - 30 dBm tone at input mixer ^a	< -70 dBc, + 40 dBm SHI	< -75 dBc, + 45 dBm SHI	
1.5 GHz to 2.0 GHz - 10 dBm tone at input mixer ^a	< -80 dBc, + 70 dBm SHI	< -85 dBc, + 75 dBm SHI	
> 2 GHz - 10 dBm tone at input mixer ^a	≤ -95 dBc, + 85 dBm TOI	< -100 dBc, + 90 dBm SHI	
WCDMA ACPR dynamic range ^b	Input terminated a	nd 0 dB attenuation	
Offset frequency 5 MHz		-60 dBc, -65 dBc, -66.5 dBc noise correction (Opt 120)	
10 MHz		-64.5 dBc, -65.5 dBc, -67 dBc noise correction (Opt 120)	
Other input related spurious			
Inband > 30 kHz offset	< -65 dBc for -20 dBm tone at input mixer ^a		
Out of band responses	< -80 dBc -10 dBm tone at input mixer ^a		
-50			

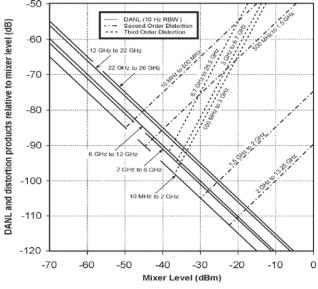


Figure 2. Specified dynamic range for E4407B spectrum analyzer

a. Mixer power level (dBm) = input power (dBm) - input attenuation (dB).
 b. Characteristic. Measured by selecting "Measure, ACP", 20 to 30 °C, 3GPP (3.1 Dec 1999) W-CDMA signal with 1 DPCH, channel power -9 dBm/3.84 MHz, integration handwidth 3.84 MHz, carrier fraguency 2 GHz, reference level -16 dBm, input

bandwidth 3.84 MHz, carrier frequency 2 GHz, reference level -16 dBm, input attenuation 0 dB, RBW 30 kHz. Noise correction can be turned on by selecting Meas Setup, More, Noise Corr On.

General Specifications

	Basic analyzer			Standard, communications test analyzer or custom configuration	
	E4411B	E4403B	E4408B	E4402B	E4404/05/07B
Temperature range					
Operating	0 °C to +55 °C				
Storage	-40 °C to +75 °C				
Disk drive			10 °C t	o +40 °C	
EMI compatibility				compliance with CISPR Pub. ance with CISPR Pub. 11/199	11/1990 Group 1 Class A 0 Group 1 Class B ^a (Option 060
Audible noise sound pressure at 25 °C	< 40 dBa pressure and $<$ 4.6 bels power (ISODP7779)				
Military specifications				al specifications of MIL-PRF-	
Power requirements		Type tested to		al specifications of MIL-PRF-	28800F class 3
	90 to 132 V rms, 47 to 440 Hz				
AC operation on (line)	195 to 250 V rms, 47 to 66 Hz				
	Power consumption < 300W				
Standby (line 🕑)	Power consumption < 5W				
DC operation			12 to 20 Vdc, <	200 W power consumption	
Data storage (nominal)					
Internal ^b	200 traces or states 8.0 MB				
External			3.5″ 1	.44 MB, MS-DOS	
Memory usage (nominal)					
State	16 kB ^C				
State plus 401- point trace	20 kB ^C				
Weight (without options)					
	13.2 kg	15.5 kg	17.1 kg	15.5 kg	17.1 kg
Kilograms	29.1 lb	34.2 lb	37.7 lb	34.2 lb	37.7 lb
Measurement speed					
Local measurement rate	\geq 35/sec	\geq 30/sec	\geq 28/sec	≥45/sec	≥40/sec
Remote measurement and GPIB transfer	\geq 30/sec	≥30/sec	≥30/sec	≥45/sec	≥40/sec
RF center freq tuning time	\leq 90 ms	\leq 90 ms	\leq 90 ms	≤75 ms	≤ 7 5 ms

a.

- Meeting class A performance during DC operation. For serial numbers < US414400 or MY41440000, 1MB without Option B72, 8 Mb with Option B72. 401 sweep points. The size of a state will increase depending on the installed application(s). C.

b.

Inputs/outputs			
Front panel			
Input	50 Ω type N (f); 75 Ω type N (f) (Option 1DP); 50 Ω APC 3.5 (m) (Option BAB)		
RF out	50 Ω type N (f); 75 Ω BNC (f) (Option 1DQ)		
Probe power	+ 15 Vdc, -12.6 Vdc at 150 mA maximum (characteristic)		
External keyboard	6-pin mini-DIN, PC keyboards (for entering screen titles and file names)		
Headphone	Front panel knob controls volume		
Power output	0.2 Ω into 4 Ω (characteristic)		
AMPT REF out	50 Ω BNC (nominal)		
IF INPUT (Option AYZ)	50 Ω SMA (nominal)		
LO OUTPUT (Option AYZ)	50 Ω SMA (nominal)		
Rear panel			
10 MHz REF OUT	50 Ω BNC (f), > 0 dBm (characteristic)		
10 MHz REF IN	50 Ω BNC (f), -15 to +10 dBm (characteristic)		
GATE TRIG/EXT TRIG IN	BNC (f), 5 V TTL		
GATE /HI SWP OUT	BNC (f), 5 V TTL		
VGA OUTPUT	VGA compatible monitor, 15-pin mini D-SUB, (31.5 kHz horizontal,		
VGA UUTFUT	60 Hz vertical sync rates, non-interlaced analog RGB 640 x 480		
IF, sweep and video ports (Option A4J or AYX	()		
AUX IF OUT	BNC (f), 21.4 MHz, nominal -10 to -70 dBm (uncorrected)		
AUX VIDEO OUT	BNC (f), 0 to 1V, characteristic (uncorrected)		
HI SWP IN	BNC (f), low stops sweep, (5 V TTL)		
HI SWP OUT	BNC (f), (5 V TTL)		
SWP OUT	BNC (f), 0 to +10 V ramp		
GPIB interface (Option A4H)	IEEE-488 bus connector		
Serial interface (Option 1AX)	RS-232, 9-pin D-SUB (m)		
Parallel interface			
(Option A4H or 1AX)	25-pin D-SUB (f) printer port only		

Option Ordering

For information on ordering options, please refer to the *ESA/EMC Spectrum Analyzer Configuration Guide*, literature number 5968-3412E.

More Information

For the latest information on the Agilent ESA-E Series see our Web page at:

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